U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE
втр	6,535,609	March 18, 2003	Finn et al.	 	 	
	6,385,176	May 7, 2002	Lyengar et al.			
	5,245,665	September 14, 1993	Lewis et al.			
	5,677,987	October 14, 1997	Seki et al.			
8ТР	2004/0158460	August 12, 2004	Finn et al.			

FOREIGN PATENT DOCUMENTS

						TRANSLATION	
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Yes	No
BTP	0 599 450	June 1, 1994	EP				
BIP	1 445 761*	January 16, 2004	EP				
317	WO 03/079721	September 25, 2003	PCT				
							

English-language Abstract provided.

INFORMATION DISCLOSURE

STATEMENT BY APPLICANT

DEC 0 6 2004

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.

EXAMINER	3	2.2	DATE CONSIDERED	10/6/	06
EXAMINER: Initi not considered. In	ial if citation	on considered, whether	r or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in	conform	ance and

INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO FORM 1449

A11y, Docket No. 11150/75	Serial No. To Be Assigned	
Applicant(s) Brian Michael FINN et al.		
Filing Date	Group	

U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

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INITIALS	NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	YES	NO
BTP	0 078 014	August 27, 1986	EP				
	WO 97/34290	September 18, 1997	PCT				
	197 05 471*."	July 24, 1997	DE				
	41 06 405***	September 26, 1991	DE				
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BTP	WO 02/069487	September 6, 2002	PCT				
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EXAMINER 3 3. 2-	DATE CONSIDERED
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.I	P.E.P. 609: draw line through citation if not in conformance and

not considered. Include copy of this form with next communication to applicant.

^{**} English-language abstract provided.